

Notice of References Cited	Application/Control No. 10/659,388		Applicant(s)/Patent Under Reexamination PARK, KYUNG CHAN	
	Examiner THOMAS D. ALUNKAL		Art Unit 2627	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,535,477	03-2003	Muramatsu et al.	369/275.4
*	B	US-2001/0036134	11-2001	Nakajima et al.	369/44.26
*	C	US-2002/0054555	05-2002	Karakawa et al.	369/53.33
*	D	US-5,737,284	04-1998	Yamada, Minoru	369/30.04
*	E	US-6,243,336	06-2001	Schell et al.	369/44.29
*	F	US-5,862,123	01-1999	Horie et al.	369/275.4
*	G	US-6,128,272	10-2000	Horimai et al.	369/44.26
*	H	US-6,125,181	09-2000	Gotoh et al.	380/2
*	I	US-2002/0001274	01-2002	Nakajima et al.	369/53.21
*	J	US-7,215,610	05-2007	Sako et al.	369/47.12
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.